A nom alous quantum transport in a thin lm

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A bstract

We present a numerical study of electron transport in a thin lm of varying disorder strength with the distance from its surface. A simple tight-binding model is used to describe the system, in which the lm is attached to two metallic electrodes and the coupling of this lm to the electrodes is illustrated by the Newns-Anderson chem isorption theory. Quite interestingly we observe that, in the sm oothly varying disordered lm current amplitude increases with the increase of disorder strength in the strong disorder regime, while it decreases in the weak disorder regime. This behavior is completely opposite from a conventional disordered lm, where current amplitude always decreases with the increase of disorder strength.

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1 Introduction

Im provem ents of nanoscience and technology have stim ulated us to investigate electrical conduction on mesoscopic/nanoscopic scale in a very tunable environm ent. The transport properties of quantum systems attached to electrodes have been studied extensively over the last few decades both theoretically as well as experim entally due to their possible technological applications. In 1974, A viram and Ratner¹ rst developed a theoretical form ulation for the description of electron conduction in a molecular electronic device. Later m any experim ents² ⁶ have been performed in several bridge systems to justify the basic mechanisms underlying the electron transport. From the num erous studies of electron transport, exist in the literature, we can able to understand di erent features, but yet the com plete know ledge of the conduction mechanism in this scale is not well established even today. M any signi cant factors are there which control the electron transport in a molecular bridge, and all these e ects have to be taken into account properly to reveal the transport. For our illustrative purpose, here we mention some of them as follows. In order to reveal the dependence of the molecular structure on the electron transport, Emzerhof et al.⁷ have performed few model calculations and predicted som e interesting results. The molecular coupling⁸ to the side attached electrodes is another important param eter that controls the electron transport in a signi cant way. The most signi cant issue is probably the e ects of quantum interferences of electron waves in dierent pathways, and several studies^{8 16} are available in the literature describing these e ects. In addition to these, dynam ical

uctuations provide an active role in the determ ination of m olecular transport which can be m anifested through the m easurement of shot noise, a direct consequence of the quantization of charge. This can be used to obtain information on a system which is not directly available through conductance m easurements, and is generally more sensitive to the e ects of electron-electron correlations than the average conductance.¹⁷¹⁸

In this article, we concentrate ourselves on a di erent aspect, related to the e ect of disorder, of quantum transport than the above mentioned issues. The characteristic properties of electron transport in conventional disordered systems are well established in the literature. But there are some special type of nano-scale materials, where the charge carriers are scattered mainly from their surface regions¹⁹ ²³ and not from the inner core

regions. These system s exhibit several peculiar features in electron transport. For example, in a very recent work Y ang et al.²¹ have shown a localization to quasi-delocalization transition in edge disordered graphene nanoribbons by varying the strength of edge disorder. Quite sim ilar in behavior has also been observed in a shell-doped nanow ire, 22 where the electron dynam ics undergoes a localization to quasi-delocalization transition beyond som e critical doping. In the shell-doped nanowire, the dopant atoms are spatially con ned within a few atom ic layers in the shell region. This is completely opposite to that of a traditional disordered nanow ire, where the dopant atom s are distributed uniform ly throughout the system . From the num erous studies of electron transport in many such system s, it can be emphasized that the surface reconstructions,²⁴ surface scattering²⁵ and surface states²⁶ may be quite signi cant to exhibit several diverse transport properties. Motivated with these investigations, here we consider a particular kind of thin In in which disorder strength varies sm oothly from layer to layer with the distance from its surface. In this system, our num erical study predicts a strange behavior of electron transport where current am plitude increases with the increase of disorder strength in the strong disorder limit, while it decreases in the limit of weak disorder. On the other hand, for a traditional disordered thin lm current am plitude always decreases with the increase of disorder strength. An analytic approach based on the tight-binding m odel is used to incorporate the electron transport in the lm, and we adopt the New ns-Anderson chem isorption model^{27 29} to describe the side attached electrodes and the interaction of these electrodes with the lm .

O ur organization of this article is as follows. In Section 2, we describe the model and the theoretical form ulation for our calculations. Section 3 discusses the signi cant results, and at the end, we sum marize our results in Section 4.

2 M odel and the theoretical description

The system of our concern is depicted in Fig. 1, where a thin lm is attached to two metallic electrodes, viz, source and drain. In this lm, disorder strength varies smoothly from the top most disordered layer (solid line) to-wards the bottom layer, keeping the lowest bottom layer (dashed line) as disorder free. The electrodes are symmetrically attached at the two extreme corners of the bottom layer. U sing the G reen's function form alism 30 and single channel Landauer conductance form ula, 30 we calculate the transm ission probability (T), conductance (g) and current (I) through the lm.

At low tem perature and bias voltage, the conductance g of the lm is obtained from the Landauer conductance form ula, 30

$$g = \frac{2e^2}{h}T$$
 (1)

where the transm ission probability T can be written in terms of the retarded and advanced G reen's functions (G $_{\rm F}^{\rm r}$ and G $_{\rm F}^{\rm a}$) of the lm as³⁰

$$T = Tr[_{S}G_{F}^{r} _{D}G_{F}^{a}] \qquad (2)$$

The parameters $_{\rm S}$ and $_{\rm D}$ describe the couplings



Figure 1: Schem atic view of a sm oothly varying disordered thin lm attached to twom etallic electrodes (source and drain). The top most front layer (solid line) is the highest disordered layer and the disorder strength decreases sm oothly to-wards the bottom layer keeping the low est bottom layer (dashed line) as disorder free. Two electrodes are attached at the two extreme corners of the bottom layer.

of the lm with the source and drain respectively. The Green's function of the lm becomes,

$$G_{\rm F} = (E \quad H_{\rm F} \quad {}_{\rm S} \quad {}_{\rm D})^{\perp} \qquad (3)$$

where E is the energy of the injecting electron and H $_{\rm F}$ corresponds to the H am iltonian of the lm. The parameters $_{\rm S}$ and $_{\rm D}$ denote the self-energies due to the coupling of the lm with the source and drain respectively, and are described by the use of N ewns-Anderson chem isorption theory.^{27 29} In the tight-binding framework, the H am iltonian can be expressed within the non-interacting picture as,

$$H_{F} = \frac{X}{i} c_{i}^{y} c_{i} + \frac{X}{t} c_{j}^{y} c_{j} + c_{j}^{y} c_{i} \qquad (4)$$

Here i gives the on-site energy of an electron at site i and t represents the hopping strength between two

nearest-neighbor sites both for the longitudinal and transverse directions of the lm. Now to achieve our concerned system, we choose the site energies ($_{i}$'s) random ly from a \Box" distribution function such that the top most front layer becom es the highest disordered layer with strength W and the strength of disorder decreases sm oothly to-wards the bottom layer as a function of W = (N $_1$ m), where N $_1$ gives the total number of layers and m represents the totalnum ber of ordered layers from the bottom side of the lm.W hile, in the conventional disordered thin In all the layers are subjected to the same disorder strength W . In our present model, the electrodes are described by the standard tight-binding H am iltonian, sim ilar to that as prescribed in Eq.(4), and param etrized by constant on-site potential 0 and nearest-neighbor hopping integralv.

A ssum ing the entire voltage is dropped across the lm-electrode interfaces,³¹ the current passing through the lm, which is regarded as a single electron scattering process between the reservoirs, can be expressed as,³⁰

$$I(V) = \frac{e^{\sum_{n=1}^{L} f_n}}{h_1} (f_s f_D) T(E) dE$$
 (5)

where $f_{S(D)} = f E_{S(D)}$ gives the Ferm idistribution function with the electrochem ical potential $_{S(D)} = E_F = eV=2$. In this article, we focus our study on the determ ination of the typical current amplitude which is obtained from the relation,

$$I_{typ} = \frac{q}{\langle I^2 \rangle_{W,V}}$$
(6)

where W and V correspond to the impurity strength and the applied bias voltage respectively.

Throughout this presentation, all the results are computed at absolute zero temperature, but they should valid even for nite temperature (300 K) as the broadening of the energy levels of the lm due to its coupling with the electrodes will be much larger than that of the thermal broadening.³⁰ For sim plicity, we take the unit c = e = h = 1 in our present calculations.

3 Results and discussion

All the num erical calculations we do here are perform ed for som e particular values of the di erent param eters, but all the basic features in which we are interested in this particular study remain also invariant for the other param etric values. The values of the di erent param eters are as follows. The coupling strengths of the lm to the electrodes are taken as S = D = 1.5, the nearest-neighbor hopping integral in the lm is xed to t = 1. The on-site potential and the hopping integral in the electrodes are set as $_0 = 0$ and v = 2 respectively. In addition to these, here we also introduce three other param eters N $_{\rm x}$, N $_{\rm y}$ and N $_{\rm z}$ to specify the system size of the thin Im, where they correspond to the total number of lattice sites along the x, y and z directions of the Im respectively. In our num erical calculations, the typical current am plitude (I_{typ}) is determined by taking the average over the disordered con gurations and bias voltages (see Eq.(6)). Since in this particular model the site energies are chosen random ly, we compute Ityp by taking the average over a large num ber (60) of disordered congurations in each case to get much accurate result. On the other hand, for the averaging over the bias voltage V, we set the range of it from 10 to 10. In this presentation, we focus only on the system s with sm all sizes since all the qualitative behaviors rem ain also invariant even for the large system s.

Figure 2 illustrates the variation of the typical current am plitude (Ityp) as a function of the disorder (W) for some thin $\ln s$ with N $_x = 10$, N $_y = 8$ and $N_z = 5$. Here we set m = 1, i.e., only the low est bottom layer is free from any disorder for these Im s. The solid and dotted curves correspond to the results of the sm oothly varying and complete disordered thin Ims respectively. A remarkably di erent behavior is observed for the sm oothly varying disordered Im compared to the Im with complete disorder. In the later system, it is observed that Ityp decreases rapidly with W and eventually it drops to zero for the higher value of W . This reduction of the current is due to the fact that the eigenstates become more localized32 with the increase of disorder, and it is well established from the theory of Anderson localization.³³ The appreciable change in the variation of the typical current am plitude takes place only for the unconventional disordered lm. In this case, the current am plitude decreases initially with W and after reaching to a minimum at $W = W_c$ (say), it again increases. Thus the anom alous behavior is observed beyond the critical disorder strength W $_{\rm c}$, and we are interested particularly in this regime where $W > W_c$. In order to illustrate this peculiar behavior, we consider the sm oothly varying disordered Im as a coupled system combining two sub-systems. The coupling exists between the lowest bottom ordered layer and the other disordered layers. Thus the system can be treated, in other way, as a coupled order-disorder separated thin Im. For this coupled system we can write the Schrödinger equations as: the term $s H_1$ and H_2 have reasonably high values.

(H₀ H_1) $_0 = E_0$ and $(H_d H_2)_d = E_d$. $\rm H\,ere\,\,H_{0}$ and $\rm H_{d}$ represent the sub-H am iltonians of the ordered and disordered regions of the lm respectively, and $_0$ and $_d$ are the corresponding eigenfunctions. The term $s H_1$ and H_2 in the above two expressions are the most signi cant and they



Figure 2: I_{typ} vs. W for somethin $lm s w ith N_x =$ 10, N_y = 8 and N_z = 5. Here we set m = 1. The solid and dotted curves correspond to the sm oothly varying and complete disordered Im s respectively.

can be expressed as: $H_1 = H_{od} (H_d - E)^{-1} H_{do}$ and $H_2 = H_{do} (H_o E)^1 H_{od} H_{od}$ and H_{do} correspond to the coupling between the ordered region and the disordered region. From these mathematical expressions, the anom alous behavior of the electron transport in the Im can be described clearly. In the absence of any interaction between the ordered and disordered regions, we can assume the full system as a simple combination of two independent subsystem s. Therefore, we get all the extended states in the ordered region, while the localized states are obtained in the disordered region. In this situation, the motion of an electron in any one region is not affected by the other. But for the coupled system, the motion of the electron is no more independent, and we have to take the combined e ects coming from both the two regions. W ith the increase of disorder, the scattering e ect becom es dom inated m ore, and thus the reduction of the current is expected. This scattering is due to the existence of the localized eigenstates in the disordered regions. Therefore, in the case of strong coupling between the two subsystems, the motion of the electron in the ordered region is signi cantly in uenced by the disordered regions. Now the degree of this coupling between the two sub-systems solely depends on the two param eters H $_1$ and H $_2$, those are expressed earlier. In the lim it of weak disorder, the scattering e ect from both the two regions is quite signi cant since then

W ith the increase of disorder, H_1 decreases gradually and for a very large value of W it becomes very small. Hence the term $(H_0 \ H_1)$ electively goes to H_0 in the limit W ! 0, which indicates that the ordered region becomes decoupled from the disordered one. Therefore, in the higher disorder regime



Figure 3: I_{typ} vs. W for some thin $lm swith N_x = 12$, $N_y = 10$ and $N_z = 6$. Here we set m = 2. The solid and dotted curves correspond to the identical meaning as in Fig.2.

the scattering e ect becom es less signi cant from the ordered region, and it decreases with W . For the low regime of W , the eigenstates of both the two e ective H am iltonians, $(H_0 H_1)$ and $(H_d H_2)$, are localized. W ith the increase of W , H $_1$ gradually decreases, resulting in much weaker localization in the states of (H $_0$ H $_1$), while the states of (H $_d$ H $_2$) becom e m ore localized. At a critical value of $W = W_{c}$ (say) (' band width of H_0), we get a separation between the much weaker localized states and the strongly localized states. Beyond this value, the weaker localized states become more extended and the strongly localized states becom e m ore localized with the increase of W . In this situation, the current is obtained mainly from these nearly extended states which provide the larger current with W in the higher disorder regime.

To illustrate the size dependence of the lm on the electron transport, in Fig. 3 we plot the variation of the typical current am plitude for some thin lm s with N_x = 12, N_y = 10 and N_z = 6. For these lm s we take m = 2, i.e., two layers from the bottom side are free from any disorder. The solid and dotted curves correspond to the identical meaning as in Fig. 2. For both the unconventional and traditional disordered lm s, we get alm ost the sim ilar behavior of the current as presented in Fig. 2. This study show s that the typical current am plitude strongly depends on the nite size of the thin lm.

4 Concluding Remarks

To summarize, we have done a numerical study to show the anom alous behavior of electron transport in a unconventional disordered thin Im where the disorder strength varies sm oothly from its surface. A simple tight-binding model has been used to describe the system, where the coupling of the In to the electrodes has been described by the Newns-Anderson chem isorption theory. We have calculated the typical current amplitudes by using the Green's function formalism, and our results have shown a remarkably di erent behavior for the unconventional disordered Im compared to the traditional disordered lm. In the smoothly varying disordered lm, the typical current am plitude decreases with W in the weak disorder regime $(W < W_{c})$, while it increases in the strong disorder regime ($W > W_{c}$). On the other hand for the conventional disordered lm, the current am plitude always decreases with disorder. In this present investigations, we have also studied the nite size e ects of the lm and our num erical results have shown that the typical current am plitude strongly depends on the size of the lm. Quite similar feature of anom alous quantum transport can also be observed in som e other lower dim ensional system s like, edge disordered graphene sheets of single-atom -thick, nite width rings with surface disorder, nanowires, etc. Our study has revealed that the carrier transport in an order-disorder separated m esoscopic device may be tailored to desired properties through doping for di erent applications.

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